





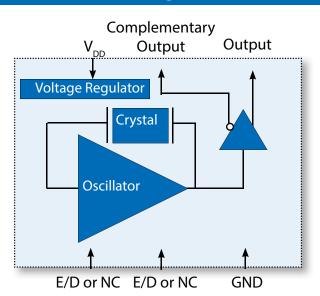
Vectron's VC-827 Crystal Oscillator is a quartz stabilized, differential output oscillator, operating off a 2.5 or 3.3 volt power supply in a hermetically sealed 3.2 x 2.5mm ceramic package.

### **Features**

- Ultra Low Jitter Performance, 3rd OT or Fundamental Crystal Design
- Extended Operating Temperature Range, -40 to 105°C
- 20MHz -170MHz Output Frequencies
- Excellent Power Supply Rejection Ratio
- Enable/Disable
- 3.3 or 2.5V operation
- Extended Operating Temperature Range (-40 to 105°C) Option
- Hermetically Sealed 3.2x2.5mm Ceramic Package
- Product is compliant to RoHS directive and fully compatible with lead free assembly

### **Applications**

- Ethernet, GbE, Synchronous Ethernet
- PCle
- Fiber Channel
- Enterprise Servers and Storage
- Clock source for ADC's, DAC's
- Test and Measurement
- GPON
- Clock source for ADC's, DAC's, FPGA's
- **Block Diagram**



### **Performance Specifications**

Parameter	Symbol	Min	Typical	Maximum	Units	
Supply Voltage <sup>1</sup> (Ordering Option)	$V_{_{DD}}$	3.135 2.375	3.3 2.5	3.465 2.625	V V	
Current Consumption, 3.3V 2.5V	I <sub>DD</sub>			69 61	mA	
		Frequency				
Nominal Frequency (Ordering Option)	f <sub>N</sub>	20		170	MHz	
Stability <sup>2</sup> (Ordering Option)		±	25, ±50 or ±10	00	ppm	
		Outputs			•	
Output Logic Levels <sup>3</sup> Output Logic High Output Logic Low	V <sub>oh</sub> V <sub>ol</sub>	V <sub>DD</sub> -1.025 V <sub>DD</sub> -1.810		V <sub>DD</sub> -0.880 V <sub>DD</sub> -1.620	V V	
Output Rise and Fall Time <sup>3,4</sup>	t <sub>R</sub> /t <sub>F</sub>			500	ps	
Load	50 ohms into V <sub>DD</sub> -2.0V					
Duty Cycle⁵	DC	45		55	%	
Phase Noise, 3.3V, 156.25MHz <sup>6</sup> 10Hz 100Hz 1kHz 10kHz 100kHz 100kHz 20MHz 40MHz	φ <sub>N</sub>		-80 -111 -134 -147 -153 -155 -156 -156		dBc/Hz	
Jitter <sup>6</sup> , 156.25MHz 12kHz -20MHz	φ		95	130	fs	
	Ena	able/Disable				
Outputs Enabled <sup>7</sup> Outputs Disabled	V <sub>IH</sub> V <sub>IL</sub>	0.7*V <sub>DD</sub>		0.3*V <sub>DD</sub>	V V	
Disable Time	t <sub>D</sub>			200	ns	
Enable/Disable Leakage Current				±200	uA	
Start-Up Time	t <sub>su</sub>			10	ms	
Operating Temp. (Ordering Option)	T <sub>OP</sub>	-10/70	°C			

1. The VC-827 power supply pin should be filtered, eg, a 10uf, 0.1uf and 0.01uf capacitor.

2. Includes calibration tolerance, operating temperature, supply voltage variations, aging and IR reflow.

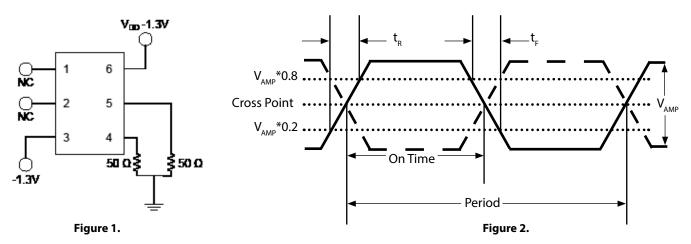
3. Figure 1 defines the test circuit and Figure 2 defines these parameters.

4. Output rise and fall time will be 600ps (max) for -40/105 °C operating temperature range.

5. Duty Cycle is defined as the On/Time Period.

6. Measured using an Agilent E5052 Signal Source Analyzer at 25 °C.

7. Outputs will be Enabled if Enable/Disable is left open.



# **Performance Specifications**

Table 2. Electrical Performance, LVDS Option									
Parameter	Symbol	Min	Typical	Maximum	Units				
Supply									
Supply Voltage <sup>1</sup> (Ordering Option)	V <sub>DD</sub>	3.135 2.375	3.3 2.5	3.465 2.625	V V				
Current Consumption, 3.3V 2.5V	I <sub>DD</sub>			33 29	mA				
	Frequency								
Nominal Frequency (Ordering Option)	f <sub>N</sub>	20		170	MHz				
Stability <sup>2</sup> (Ordering Option)		±	25, ±50 or ±10	0	ppm				
	0	utputs							
Output Logic Levels <sup>3</sup> Output Logic High Output Logic Low	V <sub>oh</sub> V <sub>ol</sub>	0.9	1.43 1.10	1.6	V V				
Output Amplitude		247	350	454	mV				
Differential Output Error				50	mV				
Offset Voltage		1.125	1.25	1.375	V				
Offset Voltage Error				50	mV				
Output Leakage Current, Outputs Disabled				10	uA				
Output Rise and Fall Time <sup>3,4</sup>	t <sub>R</sub> /t <sub>F</sub>			500	ps				
Load	100 ohms differential								
Duty Cycle⁵	DC	45		55	%				
Phase Noise, 3.3V, 156.25MHz <sup>6</sup> 10Hz 100Hz 1kHz 10kHz 100kHz 1MHz 20MHz 40MHz	φ <sub>N</sub>		-77 -107 -134 -148 -154 -156 -157 -157		dBc/Hz				
Jitter <sup>6</sup> , 156.25MHz 12kHz - 20MHz	ф		90	125	fs				
Enable/Disable									
Outputs Enabled <sup>7</sup> Outputs Disabled	V <sub>IH</sub> V <sub>IL</sub>	0.7*V <sub>DD</sub>		0.3*V <sub>DD</sub>	V V				
Disable Time	t <sub>D</sub>			200	ns				
Enable/Disable Leakage Current	I <sub>E/D</sub>			±200	uA				
Start-Up Time	t <sub>su</sub>			10	ms				
Operating Temp. (Ordering Option)	T <sub>OP</sub>	-10/70 or -40/85 or -40/105							

1. The VC-827 power supply pin should be filtered, eg, a 10uf, 0.1uf and 0.01uf capacitor.

2. Includes calibration tolerance, operating temperature, supply voltage variations, aging and IR reflow.

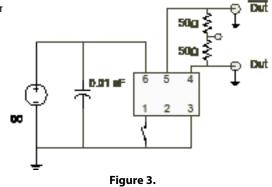
3. Figure 2 defines these parameters and Figure 3 defines the test circuit.

4. Output rise and fall time will be 600ps (max) for -40/105 °C operating temperatur

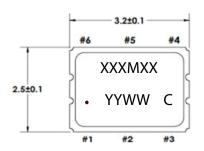
5. Duty Cycle is defined as the On/Time Period.

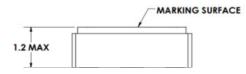
6. Measured using an Agilent E5052 Signal Source Analyzer at 25 °C

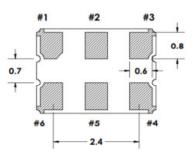
7. Outputs will be Enabled if Enable/Disable is left open.



# **Package Outline Drawing**







Dimensions in mm

Marking Information

XXXMXX - Frequency (Example: 100M00)

- YY Year of Manufacture
- WW Week of the Year
  - C Manufacturing Location

**Pin Diagram** 

• - Pin 1 Indicator

### **Recommended Pad Layout**

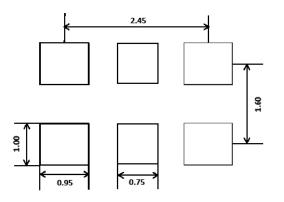
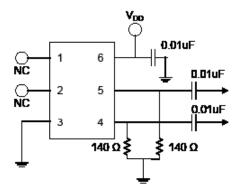
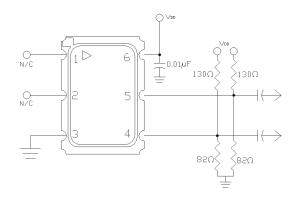


Table 3.	Table 3. Pinout							
Pin #	Symbol	Function						
1	E/D or NC	Enable/Disable or No Connection						
2	E/D or NC	Enable/Disable or No Connection						
3	GND	Electrical and Lid Ground						
4	f <sub>o</sub>	Output Frequency						
5	Cf <sub>o</sub>	Complementary Output Frequency						
6	V <sub>DD</sub>	Supply Voltage						

# **LVPECL Application Diagrams**



**Figure 4. Single Resistor Termination Scheme** Resistor values are typically 140 ohms for 3.3V operation and 84 ohms for 2.5V operation.



### Figure 5. Pull-Up Pull Down Termination

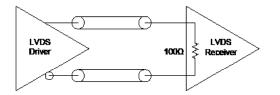
Resistor values shown are typical for 3.3 V operation. For 2.5V operation, the resistor to ground is 62 ohms and the resistor to supply is 250 ohms

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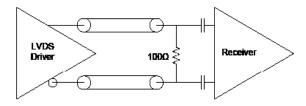
The VC-827 incorporates a standard PECL output scheme, which are un-terminated FET drains. There are numerous application notes on terminating and interfacing PECL logic and the two most common methods are a single resistor to ground, Figure 4, or for best 50 ohm matching a pull-up/pull-down scheme as shown in Figure 5 should be used. AC coupling capacitors are optional, depending on the application and the input logic requirements of the next stage.

One of the most important considerations is terminating the Output and Complementary Outputs equally. An unused output should not be left un-terminated, and if it one of the two outputs is left open it will result in excessive jitter on both. PC board layout must take this and 50 ohm impedance matching into account. Load matching and power supply noise are the main contributors to jitter related problems.

### **LVDS Application Diagrams**



**Figure 6. LVDS to LVDS Connection, Internal 100ohm Resistor** Some LVDS structures have an internal 100 ohm resistor on the input and do not need additional components. AC blocking capacitors can be used if the DC levels are incompatible.



#### Figure 7. LVDS to LVDS Connection

Some input structures may not have an internal 100 ohm resistor on the input and will need an external 100ohm resistor for impedance matching. Also, the input may have an internal DC bias which may not be compatible with LVDS levels, AC blocking capacitors can be used.

One of the most important considerations is terminating the Output and Complementary Outputs equally. An unused output should not be left un-terminated, and if it one of the two outputs is left open it will result in excessive jitter on both. PC board layout must take this and 50 ohm impedance matching into account. Load matching and power supply noise are the main contributors to jitter related problems.

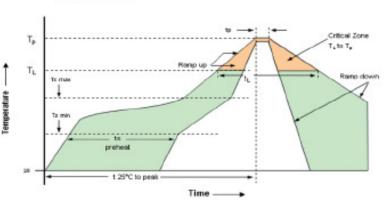
### **IR Compliance**

#### **Suggested IR Profile**

Devices are built using lead free epoxy and can be subjected to standard lead free IR reflow conditions shown in Table 4. Contact pads are gold over nickel and lower maximum temperatures can also be used, such as 220C.

Table 4. Reflow Profile		
Parameter	Symbol	Value
PreHeat Time	ts	200 sec Max
Ramp Up	R <sub>UP</sub>	3°C/sec Max
Time above 217°C	tL	150 sec Max
Time to Peak Temperature	tAMB-P	480 sec Max
Time at 260°C	tP	30 sec Max
Time at 240°C	tP2	60 sec Max
Ramp down	R <sub>dn</sub>	6°C/sec Max

### Solderprofile:



### **Environmental Compliance**

Table 5. Environmental Compliance					
Parameter	Condition				
Mechanical Shock	MIL-STD-883 Method 2002				
Mechanical Vibration	MIL-STD-883 Method 2007				
Temperature Cycle	MIL-STD-883 Method 1010				
Solderability	MIL-STD-883 Method 2003				
Fine and Gross Leak	MIL-STD-883 Method 1014				
Resistance to Solvents	MIL-STD-202 Method 215				
Moisture Sensitivity Level	MSL1				
Contact Pads	Gold (0.3-1.0um) over Nickel				
ThetaJC (bottom of case)	23 °C/W				

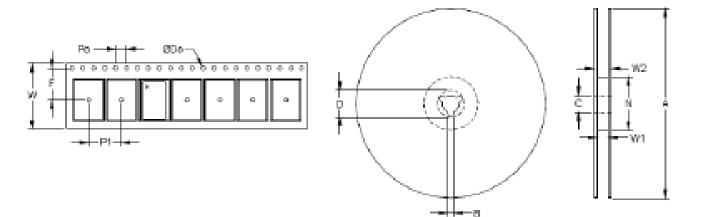
### Maximum Ratings, Tape & Reel

### **Absolute Maximum Ratings and Handling Precautions**

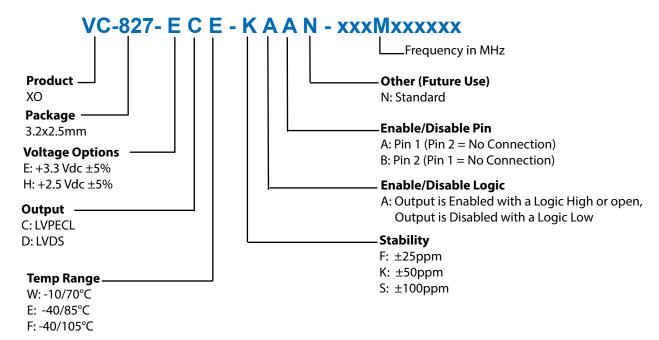
Stresses in excess of the absolute maximum ratings can permanently damage the device. Functional operation is not implied or any other excess of conditions represented in the operational sections of this data sheet. Exposure to absolute maximum ratings for extended periods may adversely affect device reliability. Although ESD protection circuitry has been designed into the VC-827, proper precautions should be taken when handling and mounting, VI employs a Human Body Model and Charged Device Model for ESD susceptibility testing and design evaluation. ESD thresholds are dependent on the circuit parameters used to define the model. Although no industry standard has been adopted for the CDM a standard resistance of 1.5kOhms and capacitance of 100pF is widely used and therefor can be used for comparison purposes.

Table 6. Maximum Ratings		
Parameter		Unit
Storage Temperature	-55 to 125	°C
Junction Temperature	150	°C
Supply Voltage	-0.5 to 5.0	V
Enable Disable Voltage	-0.5 to V <sub>DD</sub> +0.5	V
ESD, Human Body Model	1500	V
ESD, Charged Device Model	1500	V

Table 7.	Table 7. Tape and Reel Information											
Tape Dimensions (mm)			Reel Dimensions (mm)									
w	F	Do	Ро	P1	A	В	С	D	Ν	W1	W2	#/Reel
8	3.5	1.5	4	4	178	2	13	21	60	10	14	1000



# **Ordering Information**





# \* Add **\_SNPBDIP** for tin lead solder dip Example: VC-827-ECE-KAAN-156M250000\_SNPBDIP

#### Notes:

a) Only  $\pm 100$  ppm stability option is available for temperature range of -40/105 °C.  $\pm 50$  ppm is available in some cases.

b) Not all combinations of options are available. Other specifications may be available upon request. Consult with factory.

### **Revision History**

Revision Date	Approved	Description
Dec 07, 2016	RC	Rev 0.0: VC-827 Preliminary datasheet for factory approval (Internal Revision)
May 31, 2017	VN	Rev 0.1: Internal Revision based on factory information
June 14, 2017	VN	Rev 0.2: Initial Product Release in Website
Sept 06, 2018	FB	Update logo and contact info, add thetaJC, add SNPBDIP ordering option



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